Form PTO-1449 (Modified)							Atty. Docket No. 1391-27809		Serial No. 10/790,287			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)						Applicant Christopher Jones et al.						
							Filing Date		Group			
DEFERENCE I	PESICNATION	U.S. PATENT DO	CHMENTS			March 1,	2004	2878				
EXAMINER INJUDIA	ESIGNATION	DOCUMENT NUMBER	DATE	NAME		CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE				
1012	` \\\^*	4951287	08/21/1990	Wyeth et al.		372	32					
AIR OC	ign B.	4990780	02/05/1991	Lee et al.		250	343					
AIR Z J ZOK	ယ် မာ AC•	5317156	05/31/1994	Cooper et al.		250	345					
MADEMAN CHI	AD*	5640014	06/17/1997	Sauke et al.		250	339.03	05/22/1996				
00	AE*	5841533	11/24/1998	Atkinson		356	326	06/13/1997				
೦೧	AF*	5864398	01/26/1996	Murnick		365	311	06/06/1995				
<u>oc</u>	AG*	5929442	07/27/1999	Higashi		250	339.13	03/27/1997				
<i>OG</i>	АН*	5957858	09/28/1999	Micheels et al.		600	529	12/10/1996				
<u> SG</u>	AI*	4492862	01/08/1985	Grynberg et al.		250	255					
<i>∞</i>	AJ*	4517461	05/14/1985	Crandall		250	282					
OC	AK*	6202470	03/20/2001	Chou		73	24.02	08/31/1999 、				
೦	AL*	6483589	11/19/2002	Suzuki et al.		356	437	07/06/2000				
α	AM*	2001/0025927	10/04/2001	Ankerhold		250	338.5	02/28/2001				
06	AN*	5747809	05/05/1998	Eckstrom		250	345	06/11/1996				
<u> </u>	AO*	4922747	05/08/1990	Wall		73	61.1					
<u> </u>	AP*	5445964	08/29/1995	Lee et al.		463	60	05/11/1994				
00	AQ*	5543621	08/06/1996	Sauk	te et al.	250	339.03	05/15/199)5			
FOREIGN PAT	ENT DOCUM!	DOCUMENT	DATE		COUNTRY	CLASS	SUB-	Translation				
		NUMBER	DATE			02.125	CLASS	YES	NO			
०८	AR*	DE19962589	19.07.2001		Germany							
৩८	AS*	EP0426232A2	04/08/1991		EPO							
\cdot	AT*	JP9297061	07/27/1999		JAPAN				<u> </u>			
_೦೮	AU*	JP11094737	07/09/1999		JAPAN							
ં ડ	AV*	EP1111370	06/27/2001		ЕРО			_				
<u> </u>	AW*	EP1111369	06/27/2001		EPO							
- ೨೦	AX*	JP4364442	12/16/1992		JAPAN							
<u> </u>	AY*	JP5340872	12/24/1993		JAPAN			ļ				
00	AZ*	JP6018411	01/25/1994		JAPAN				<u> </u>			
1	Including Author BA*	or, Title, Date, Pert Uehara et al., Isoto			imental Substances by a New Laser-Spec	troscopic Me	ethod Utilizin	g Different				
00	BB*	Uchara et al., Isotope Analysis of Environmental Substances by a New Laser-Spectroscopic Method Utilizing Different Pathlengths, Sensors and Actuators B 74 (2001) pp. 173-178 Becker et al., Stable Isotope Analyssis Using Tunable Diode Laser Spectroscopy, Applied Optics, April 20, 1992, Vol. 31, No. 12,										
00-	рр. 1921-1927											
OG- EXAMINER	BC*	European Search	κεροπ for Europ	ean Ap	DATE CONSIDERED .	DERED (
[2/13/0]												
	EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP '609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.											

^{*} PREVIOUSLY CITED IN PARENT CASE

Form PTO-1449	(Modified)				Atty. Doc	ket No.	Serial No			
INFORMATION DISCLOPURE STAFFMENT BY APPLICANT						1391-27809 10/790,287				
(Use several sheets if necessary)						Applicant Christopher Jones et al.				
OCT 2 5 2004 &						Filing Date March 1, 2004		Group 2878		
REFERENCE I	ESIGNATION	LA PATENT DO	OCIONENTS_							
EXAMINER INITIAL		DOCUMEAGEN NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE			
				· · · · · · · · · · · · · · · · · · ·						
FOREIGN PAT	ENT DOCUM		Laten	COLUMNY		l ovin				
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	Translati YES	NO		
						<u> </u>		ļ		
						<u> </u>				
	<u> </u>		<u> </u>	- L				<u> </u>		
OTHER ART (including Author	or, Title, Date, Peri	tinent Pages, Etc	r.)						
<i>o</i> G	AA*	Woltemate et al., Carbon and Hydrogen Isotopic Composition of Bacterial Methane in a Shallow Freshwater Lake, Limnol Oceanogr., pgs. 985-992 (1984)								
00	AB*	Blair, The \$13 of Biogenic Methane in Marine Sediments: the influence of C org Deposition Rate. Chemical Geology 152 (1998) 139-150								
०८	AC*	Berner et al., Primary Cracking of Algal and Landplant Kerogens: Kinetic Models of Isotope Variations in Methane, Ethane and Propane, Chemical Geology 126 (1995) pp. 233-245								
EXAMINER	10/10	l Ga	he	DATE CONSIDERED	12/13/04					
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP '609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.										
and not considered. Include copy of this form with next communication to the approximation										

^{*} PREVIOUSLY SUBMITTED WITH AFFIDAVIT OF CHRISTOPHER JONES -